

**Notice of References Cited**

Application/Control No.

09/520,479

Applicant(s)/Patent Under  
Reexamination  
NEVEN ET AL.

Examiner

Nhon (Gary) D Nguyen

Art Unit

2174

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,609,147	08-2003	Matsuda et al.	709/205
	B	US-6,227,974	05-2001	Eilat et al.	463/40
	C	US-5,977,968	11-1999	Le Blanc, Andrew D.	345/706
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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